

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Date Submitted to PTO: [DATE]			ATTY DOCKET NO. 03500.015726.		APPLICATION NO 09/941,595	
APPLICANT Takeo Tsukamoto			FILING DATE 08/30/01		GROUP 2879	
U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>My</i>	5,982,091	11/99	Konishi	313	495	
	2002/0031972 A1	03/02	Kitamura et al.	445	3	08/29/01
	6,400,091 B1	06/02	Deguchi et al.	315	169.1	03/14/00
	6,472,814 B1	10/02	Yamanobe et al.	313	495	11/13/98
	5,872,422	02/99	Xu et al.	313	311	
	6,087,765	07/00	Coll et al.	313	309	
	2002/0009637A1	01/02	Murakami et al.	429	213	02/05/01
	5,773,921	06/30/98	Keesman et al.	313	309	
	5,935,639	8/10/99	Sullivan et al.	427	78	
	4,956,578	9/11/90	Shimizu et al.	315	3	
	5,185,554	2/9/93	Nomura et al.	313	495	
	6,448,709	9/02	Chuang et al.	313	497	
	6,204,597	03/01	Xie et al.	313	310	
	5,577,943	11/96	Vickers et al.	445	24	
	2002/136896	09/26/00	Takikawa et al.	428	408	05/06/02
	5,192,240	03/09/93	Komatsu	445	24	
	5,214,346	05/25/93	Komatsu	313	309	
	5,382,867	01/17/95	Maruo et al.	313	309	
	5,612,587	03/18/97	Itoh et al.	313	309	
	6,313,572 B1	11/06/01	Yamada	313	310	02/04/99
	6,135,839	10/24/00	Iwase et al.	445	24	01/25/99
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<i>MA</i>	6,283,812 B1	09/01	Jin et al.	445	24	
	2001/0006232	07/05/01	Choi et al.	257	10	
	4,816,289	03/89	Komatsu et al	423	447.3	
	5,443,859	08/95	Nagata	427	122	
	5,618,875	04/97	Baker et al.	524	495	
	5,690,997	11/97	Grow	427	249.1	
	6,129,602	10/00	Yamanobe	445	24	
	6,228,904	05/01	Yadav et al.	523	210	
	6,333,016	12/01	Resasco et al.	423	447.3	09/03/99
	6,413,487	07/02	Resasco et al.	423	447.3	06/02/00
	6,445,006	09/02	Brandes et al.	257	76	07/27/99
	5,981,305	11/99	Hattori	438	20	
	6,290,564	9/01	Talin et al.	445	50	09/30/99
	5,458,784	10/95	Baker et al.	210	674	
	6,331,690 B1	12/01	Yudasaka et al.	219	121.6	05/03/00
	5,965,267	10/99	Nolan et al.	428	408	
	6,309,612 B1	05/02	Kotaki et al.	347	85	08/25/00
	5,872,541	02/99	Yoshioka et al.	345	74.1	
<i>MA</i>	5,543,684	08/96	Kumar et al.	313	495	
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*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS FILING DATE IF APPROPRIATE
MJ	5,551,903	9/96	Kumar et al.	445	24
	4,900,483	2/90	Witzke et al.	313	309
	5,500,200	3/96	Mandeville et al.	423	447.3
	5,726,524	3/98	Debe	313	309
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	5,770,918	6/98	Kawate et al.	313	495
	5,185,554	2/93	Nomura et al.	313	495
	2002/0146958 A1	10/02	Ono et al.	445	24
	2003/0048056 A1	3/03	Kitamura et al.	313	311
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ME	0 535 953 B1	01/96	EPO	H01J	1/30 English
	0 290 026 B1	02/93	EPO	H01J	3/02 English
	1 122 344 A2	08/01	EPO	D01F	9/127 English
	WO 01/93292 A1	12/01	PCT	H01J	1/304 English
	WO 89/07163	08/10/89	Japan	D01F	9/12 English
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	0 758 028 A2	02/12/97	EPO	D01F	9/127 English
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	WO 98/05920	02/12/98	PCT	G01B	7/34 English
	0 394 698 A2	10/31/90	EPO	H01J	1/30 English
	2000/277003	10/06/00	Japan	H01J	9/02 Counterpart U.S. Patent 2002/136896
	0 797 233 A2	09/24/97	EPO	H01J	1/30 English
	0 980 089 A1	02/16/00	EPO	H01J	1/30 English
	0 986 084 A2	03/15/00	EPO	H01J	1/30 English
✓	1 117 118 A1	07/18/01	EPO	H01J	1/312 English
	0 716 439 A1	06/12/96	EPO	H01J	3/02 English
EXAMINER <i>ME</i>			DATE CONSIDERED <i>10/23/05</i>		

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<i>MA</i>	2-112125	04/24/90	JAPAN	H01J	1/30 Abst. & Counterpart U.S. Patent 4,956,578
	3-20941	01/29/91	JAPAN	H01J	31/12 Abst. & Counterpart U.S. Patent 5,165,554
	5-211029	08/20/93	JAPAN	H01J	1/30 No
	8-264109	10/11/96	JAPAN	H01J	1/30 Abst.
	9-82214	3/28/97	JAPAN	H01J	1/30 Abst. & European Equivalent 0 716 439
	1 113 478 A1	07/01	EPO	H01J	3/02 English
	09-188600	07/22/97	Japan	C30B	29/62 Abst.
	A1 443 865	08/28/91	EPO	H01J	21/10 English
	04-212236	08/03/92	Japan	H01J	1/30 Counterpart U.S. Patents 5,192,240, 5,214,348 & EP 0 443 865
	03-295131	12/26/91	Japan	H01J	1/30 Counterpart U.S. Patents 5,192,240, 5,214,348 & EP 0 443 865
	05-159696	06/25/93	Japan	H01J	1/30 Counterpart U.S. Patents 5,382,867 & EP 0 535 953
	05-198253	08/06/93	Japan	H01J	1/30 Counterpart U.S. Patents 5,382,867 & EP 0 535 953
<i>U</i>	05-274997	10/22/93	Japan	H01J	1/30 Abst. & Counterpart U.S. Patent 5,612,587
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<i>MA</i>	11-232997	08/27/99	Japan	H01J	1/30	Counterpart U.S. Patent 6,313,572 & EP 0 836 650
	A1 936 650	08/18/99	EPO	H01J	3/02	English
	10-289650	10/27/98	Japan	H01J	1/30	Counterpart U.S. Patent 6,135,839 & EP 0 871 195
	A1 871 195	10/14/98	EPO	H01J	1/30	English
	0 614 209 A1	9/94	EPO	H01J	31/12	English
	7-6714	1/95	Japan	H01J	31/12	Abst. & European Counterpart 0 614 209
	0 290 026 A1	11/88	EPO	H01J	3/02	English
	0 535 953 A2	4/93	EPO	H01J	1/30	English
	1 022 763 A1	7/00	EPO	H01J	9/02	English
	2000-223005	8/00	Japan	H01J	1/304	Abst. & Counterpart U.S. Patent 6,283,812
	0 836 217 A1	04/98	EPO	H01J	29/94	English
	WO 99/58748	11/99	PCT	D01F	9/127	English
	CN 1181607A	5/98	China			English Counterparts 0 836 217 & 99/58748
	1 187 161 A2	03/13/02	EPO	H01J	3/02	English
	1 102 299 A1	5/01	EPO	H01J	1/30	English
	1 096 533 A1	5/01	EPO	H01J	9/02	English
<i>✓</i>	WO 01/26130 A1	4/01	WIPO	H01J	9/20	English
EXAMINER <i>[Signature]</i>			DATE CONSIDERED <i>10/23/07</i>			

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	1 120 877 A1	8/01	EPO	H02G	5/06	English
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	2000-86216	3/00	JAPAN	C01B	31/02	Abst.
	2000-90809	3/00	JAPAN	H01J	1/304	Abst.
	2001-288625 A	10/01	Japan	D01F	9/127	Abst., Counterpart U.S. Patent 2002/00009637 & EP 1 122 344
	0 433 507 A1	6/91	EPO	D01F	9/127	English
	03-260119	11/91	Japan	D01F	9/127	Abst. & Counterpart U.S. Patent 4,900,483
	2001-52598	2/01	Japan	H01J	1/316	Abst.
	2000-95509	4/00	Japan	C01B	31/02	Abst.
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	2000-208028	7/00	Japan	H01J	1/304	Abst.
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<i>✓</i>	0 913 508 A3	5/99	EPO	D01F	9/127	English

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<i>ms</i>	R.T.K. Baker et al., "Formation of Carbonaceous Deposits from the Platinum-Iron Catalyst and Decomposition of Acetylene," 37 J. Catal. 101-105 (1975).		
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